

Application Specific Discretes A.S.D.TM

FEATURES

- UNIDIRECTIONAL FUNCTION
- PROGRAMMABLE BREAKDOWN VOLTAGE UP TO 265 V
- PROGRAMMABLE CURRENT LIMITATION FROM 50 mA TO 550 mA
- HIGH SURGE CURRENT CAPABILITY
 IPP = 100A 10/1000 μs

DESCRIPTION

Dedicated to sensitive telecom equipment protection, this device can provide both voltage protection and current limitation with a very tight tolerance.

Its high surge current capability makes the L3100B a reliable protection device for very exposed equipment, or when series resistors are very low.

The breakdown voltage can be easily programmed by using an external zener diode.

A multiple protection mode can also be performed when using several zener diodes, providing each line interface with an optimized protection level.

The current limiting function is achieved with the use of a resistor between the gate N and the cathode. The value of the resistor will determine the level of the desired current.

COMPLIES WITH THE FOLLOWING STANDARDS :

CCITT K17 - K20	10/700 μs	1.5	kV
	5/310 μs	38	А
VDE 0433	10/700 μs	2	kV
	5/200 μs	50	А
CNET	0.5/700 μs	1.5	kV
	0.2/310 μs	38	А

OVERVOLTAGE AND OVERCURRENT PROTECTION FOR TELECOM LINE



SCHEMATIC DIAGRAM



CONNECTION DIAGRAM



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ABSOLUTE MAXIMUM RATINGS (T_{amb}= 25 °C)

Symbol	Parameter	Value	Unit
IPP	Peak pulse current (see note 1)	100 250	A
Ітѕм	Non repetitive surge peak on-state current	50	A
T _{stg} Tj	Storage temperature range Maximum operating junction temperature	- 40 to + 150 + 150	°C ℃
TL	Maximum lead temperature for soldering	230	°C

Note 1 : Pulse waveform $10/1000 \, \mu s$



THERMAL RESISTANCE

Symbol	Parameter	Value	Unit
R _{th (j-a)}	Junction-to-ambient	80	°C/W

57

ELECTRICAL CHARACTERISTICS (Tamb = 25 °C)			
Symbol	Parameter		
Vrm	Stand-off voltage		
I _{RM}	Reverseleakagecurrent		
V_{BR}	Breakdown voltage		
V _{BO}	Breakovervoltage		
Ін	Holding current		
I _{BO}	Breakover current		
I _{PP}	Peak pulse current		
V_{GN}	Gate voltage		
I _{GN} , I _{GP}	Triggering gate current		
VRGN	Reverse gate voltage		
С	Capacitance		



OPERATION WITHOUT GATE

	I _{RM} @ V _{RM}		V _{BR} @l _R		V _{BO}	@	во	I _H	С
Туре	max.		min.		max.	min.	max.	min.	max.
						note 1		note 1	note 2
	μΑ	v	V	mA	v	mA	mA	mA	pF
L3100B	6 40	60 250	265	1	350	200	500	280	100
L3100B1	6 40	60 250	255	1	350	200	500	210	100

OPERATION WITH GATES

	V _{GN} @ I _{GN} = 200 mA		I _{GN} @ V _{AC} = 100V		V _{RGN} @ I _G = 1mA	I _{GP} @ V _{AC} = 100V	
Туре	min.	max.	min.	max.	min.	max.	
	v	v	mA	mA	v	mA	
L3100B/B1	0.6	1.8	30	200	0.7	150	

Note 1: See the reference test circuits for I_H, I_{BO} and V_{BO} parameters. Note 2: $V_R = 5 V$, F = 1MHz.

57

3/8



FUNCTIONAL HOLDING CURRENT (I_H) TEST CIRCUIT = GO - NOGO TEST.



Figure 1 : Surge peak current versus overload duration.

Figure 2 : Relative variation of holding current versus junction temperature.





Figure 3 : Relative variation of breakdown voltage versus ambient temperature.



Figure 4 : Junction capacitance versus reverse applied voltage.



57

APPLICATION CIRCUIT

Overvoltage Protection and Current limitation



Table below gives the tolerance of the limited current I_T for each standardized resistor value. The formula (1) has been used with V_{GN} values specified at the typical gate current level I_{GN} .

CURRENT TOLERANCE		RANCE	
R Ω (±5%)	lτ mA min	Iт mA max	
3.00 3.30 3.60 3.90 4.30 4.70 5.10 5.60 6.20 6.20 6.80 7.50 8.20 9.10 10.10 11.00 12.00 13.00 15.00	268 246 228 213 196 181 170 158 145 135 152 117 108 101 95 90 85 78	533 503 478 456 433 413 396 379 361 347 333 322 310 299 291 283 277 266	$I_{T} = \frac{V_{GN}}{Ra} + I_{GN}$
16.00 18.00	75 70	263 256	Vgn @ Ign
20.00	66 62	250	Min. Max. Typ.
24.00 27.00	60 56	242 237	V V mA
30.00	54	233	0.75 0.95 100

57

6/8



PROTECTION MODES :

ON HOOK = Ringer circuit protection is ensured with breakdown voltage at 265 V.

OFF HOOK = In dialing mode and in speech mode, the breakdown voltage of L3100B can be adapted to different levels with zener diodes.

ORDER CODE



MARKING : Logo, Date Code,part Number.



PACKAGE MECHANICAL DATA. DIL 8 (Plastic)



Weight: 0.59 g

Packaging : Product supplied in antistatic tubes.

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8/8